



N- and P-Channel for Level Shift Load Switch

PRODUCT SUMMARY						
	V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A)	Q _g (Typ.)		
	20	0.225 at $V_{GS} = 4.5 \text{ V}$	1.5 ^a			
N-Channel		0.270 at $V_{GS} = 2.5 \text{ V}$	1.5 ^a	1.1 nC		
		0.345 at $V_{GS} = 1.8 \text{ V}$	1.5 ^a	1.1110		
		0.960 at $V_{GS} = 1.5 \text{ V}$	0.5			
P-Channel	- 12	0.057 at $V_{GS} = -4.5 \text{ V}$	- 4.5 ^a			
		0.077 at $V_{GS} = -2.5 \text{ V}$	- 4.5 ^a	5 nC		
	- 12	0.115 at $V_{GS} = -1.8 \text{ V}$	- 4.5 ^a	3110		
		0.200 at $V_{GS} = -1.5 \text{ V}$	- 1.5			

FEATURES

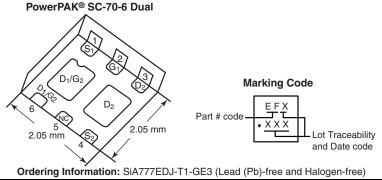
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFETs
- Typical ESD Protection: N-Channel 2800 V P-Channel 1900 V
- 100 % R_g Tested Compliant to RoHS Directive 2002/95/EC

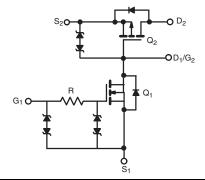


HALOGEN **FREE**

APPLICATIONS

- Load Switch with Level Shift for Portable Devices
 - N-Channel for Level Shift Drive
 - P-Channel for Main Switch





ABSOLUTE MAXIMUM RATINGS T _A = 25 °C, unless otherwise noted							
Parameter		Symbol	N-Channel	P-Channel	Unit		
Drain-Source Voltage		V_{DS}	V _{DS} 20		V		
Gate-Source Voltage	V_{GS}	± 6	± 8	V			
	T _C = 25 °C		1.5 ^a	- 4.5 ^a			
Continuous Drain Current /T 150 °C)	T _C = 70 °C		1.5 ^a	- 4.5 ^a			
Continuous Drain Current (T _J = 150 °C)	T _A = 25 °C	l _D	1.5 ^{a, b, c}	- 4.5 ^{a, b, c}			
	T _A = 70 °C		1.5 ^{a, b, c}	- 3.9 ^{b, c}	Α		
Pulsed Drain Current		I _{DM}	4	- 15	1		
Source Drain Current Diode Current	T _C = 25 °C	I.	1.5 ^a	- 4.5 ^a			
Source Drain Current Diode Current	T _A = 25 °C	I _S	1.6 ^{b, c}	- 1.6 ^{b, c}			
	T _C = 25 °C		5	7.8			
Mariana Barra Birahari	T _C = 70 °C	P _D	3.2	5	W		
Maximum Power Dissipation	T _A = 25 °C		1.9 ^{b, c}	1.9 ^{b, c}	VV		
	T _A = 70 °C		1.2 ^{b, c}	1.2 ^{b, c}			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 150		°C		
Soldering Recommendations (Peak Temperature) ^{d, e}			2	260			

THERMAL RESISTANCE RATINGS								
		N-Ch	annel	P-Ch	annel			
Parameter		Symbol	Тур.	Max.	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R _{thJA}	52	65	52	65	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	20	25	12.5	16	0/ * *	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- d. See solder profile (www.vishay.com/doc?73257). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components. f. Maximum under steady state conditions for channel 1 and channel 2 is 110 °C/W.

SiA777EDJ

Vishay Siliconix



SPECIFICATIONS $T_J = 25 ^{\circ}C$	C, unless other	erwise noted					
Parameter	Symbol	Test Conditions		Min.	Тур.	Max.	Unit
Static				•			
Drain-Source Breakdown Voltage	V	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	N-Ch	20			V
	V_{DS}	$V_{GS} = 0 \text{ V, I}_{D} = -250 \mu\text{A}$	P-Ch	- 12			V
V Tomporatura Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA	N-Ch		21		
V _{DS} Temperature Coefficient	ΔVDS/1J	I _D = - 250 μA	P-Ch		- 3		mV/°C
V _{GS(th)} Temperature Coefficient	Δ\/ /T -	I _D = 250 μA	N-Ch		- 2.3		
VGS(th) Temperature Coemcient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA	P-Ch		2.3		
Cata Threshold Voltage	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	N-Ch	0.4		1.0	V
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	P-Ch	- 0.4		- 1	
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 3 \text{ V}$	N-Ch			± 1	μΑ
Cata Bady Laskage	l	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$	P-Ch			± 0.5	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 6 \text{ V}$	N-Ch			± 1	mA
		$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	P-Ch			± 3	
		V _{DS} = 20 V, V _{GS} = 0 V	N-Ch			1	μΑ
Zana Oaka Wallana Basia Oamaal		V _{DS} = - 12 V, V _{GS} = 0 V	P-Ch			- 1	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$	N-Ch			10	
		V _{DS} = - 12 V, V _{GS} = 0 V, T _J = 55 °C	P-Ch			- 10	
b		$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	N-Ch	4			A
On-State Drain Current ^b	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	P-Ch	- 10			
		$V_{GS} = 4.5 \text{ V}, I_D = 1.6 \text{ A}$	N-Ch		0.183	0.225	Ω
		V _{GS} = - 4.5 V, I _D = - 3.8 A	P-Ch		0.047	0.057	
		V _{GS} = 2.5 V, I _D = 1.5 A	N-Ch		0.220	0.270	
		V _{GS} = - 2.5 V, I _D = - 3.3 A	P-Ch		0.063	0.077	
Drain-Source On-State Resistance ^b	R _{DS(on)}	V _{GS} = 1.8 V, I _D = 1.3 A	N-Ch		0.275	0.345	
		V _{GS} = - 1.8 V, I _D = 2.6 A	P-Ch		0.095	0.115	
		$V_{GS} = 1.5 \text{ V}, I_D = 0.3 \text{ A}$	N-Ch		0.320	0.960	
		V _{GS} = - 1.5 V, I _D = 1 A	P-Ch		0.125	0.200	
b	_	$V_{DS} = 10 \text{ V}, I_D = 1.6 \text{ A}$	N-Ch		3.5		
Forward Transconductance ^b	9 _{fs}	V _{DS} = - 10 V, I _D = - 3.8 A	P-Ch		11		S
Dynamic ^a	•				_		
•		$V_{DS} = 10 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 1.7 \text{ A}$	N-Ch		1.3	2.2	
Total Gate Charge		$V_{DS} = -6 \text{ V}, V_{GS} = -8 \text{ V}, I_{D} = -4.9 \text{ A}$	P-Ch		7.5	12	1
	Q_g		N-Ch		1.1	1.7	
		N-Channel	P-Ch		5	8	
Gate-Source Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 1.7 \text{ A}$	N-Ch		0.2		nC
	Q_{gs}	P-Channel	P-Ch		0.6		
Gate-Drain Charge		$V_{DS} = -6 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -4.9 \text{ A}$	N-Ch		0.1		
	Q_gd	25 7 45 2 7 5 110 11	P-Ch		1.8		
		f = 1 MHz	N-Ch	40	200	400	_
Gate Resistance	R_g		P-Ch	2	10	20	Ω

a. Guaranteed by design, not subject to production testing. b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.





SPECIFICATIONS $T_J = 25$ °C, unless otherwise noted									
Parameter	Symbol	Test Conditions		Min.	Тур.	Max.	Unit		
Dynamic ^a									
Turn-On Delay Time	t _{d(on)}		N-Ch		20	30			
Turn on Belay Time	'd(on)	N-Channel $V_{DD} = 10 \text{ V, } R_L = 7.7 \Omega$	P-Ch		20	30			
Rise Time	t _r	$I_D \cong 1.3 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$	N-Ch		12	20			
Tilge Tillle	ч	$ID = 1.3 \text{ A}, V_{GEN} - 4.3 \text{ V}, II_{g} - 1.22$	P-Ch		20	30	ns		
Turn-Off Delay Time	t _{d(off)}	P-Channel	N-Ch		70	105			
Turn-On Delay Time	•а(оп)	$V_{DD} = -6 \text{ V}, R_L = 1.5 \Omega$	P-Ch		32	50			
Fall Time	t _f	$I_D \cong -3.9 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_q = 1 \Omega$	N-Ch		20	30			
raii riirie	ተ	•	P-Ch		16	25			
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C	N-Ch			1.5			
Continuous Source-Diam Diode Current	'5	.0 = 20 0	P-Ch			- 4.5	Α		
Pulse Diode Forward Current ^a	I _{SM}		N-Ch			4	^		
Pulse Diode Forward Current	'SM		P-Ch			- 15			
Dady Diada Valtana	V	$I_S = 1.3 \text{ A}, V_{GS} = 0 \text{ V}$	N-Ch		0.9	1.2	٧		
Body Diode Voltage	V_{SD}	I _S = - 3.9 A, V _{GS} = 0 V	P-Ch		- 0.8	- 1.2	V		
Dady Diada Dayana Dagayan Tima			N-Ch		50	75			
Body Diode Reverse Recovery Time	t _{rr}		P-Ch		45	70	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	N-Channel	N-Ch		30	45			
		$I_F = 1.3 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	P-Ch		25	40	nC		
Deverage December Fell Times		P-Channel	N-Ch		15				
Reverse Recovery Fall Time	t _a	$I_F = -3.9 \text{ A}, \text{ dI/dt} = -100 \text{ A/µs}, T_{.I} = 25 ^{\circ}\text{C}$	P-Ch		15				
D D D: T	t _b		N-Ch		35		ns		
Reverse Recovery Rise Time			P-Ch		30				

Notes:

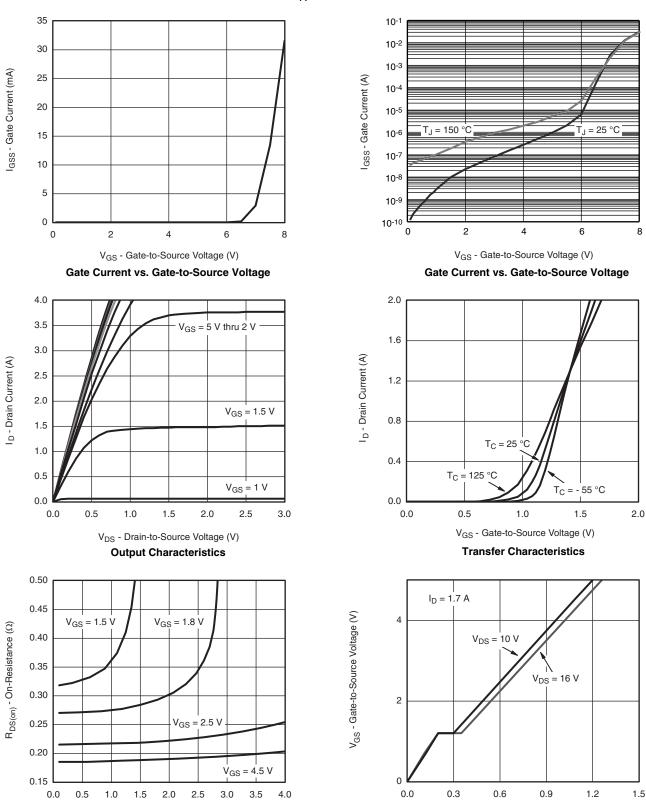
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Guaranteed by design, not subject to production testing.

b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %.



N-CHANNEL TYPICAL CHARACTERISTICS $T_A = 25~^{\circ}C$, unless otherwise noted



I_D - Drain Current (A)

On-Resistance vs. Drain Current

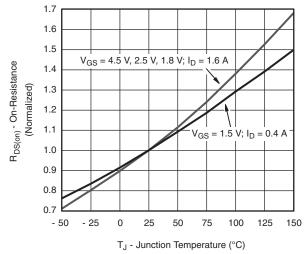
Q_q - Total Gate Charge (nC)

Gate Charge

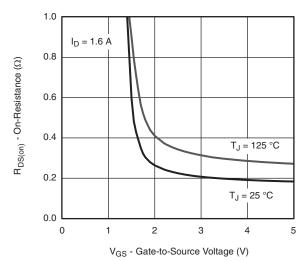




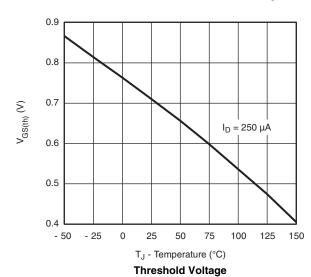
N-CHANNEL TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted

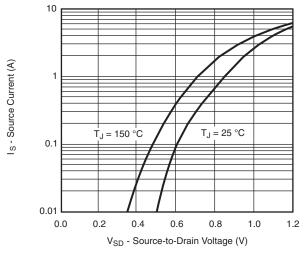


Normalized On-Resistance vs. Junction Temperature

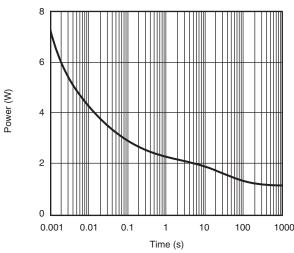


On-Resistance vs. Gate-to-Source Voltage

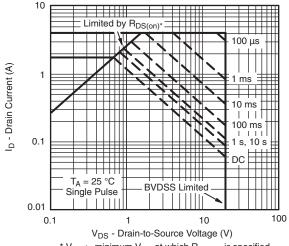




Source-Drain Diode Forward Voltage



Single Pulse Power, Junction-to-Ambient

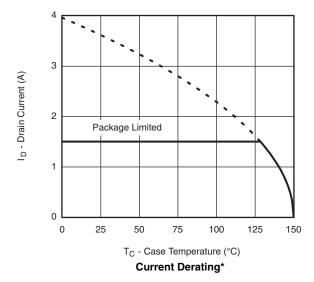


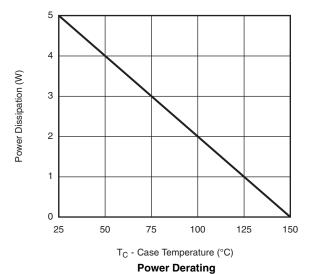
* V_{GS} > minimum V_{GS} at which R_{DS(on)} is specified

Safe Operating Area, Junction-to-Ambient



N-CHANNEL TYPICAL CHARACTERISTICS $T_A = 25~^{\circ}\text{C}$, unless otherwise noted

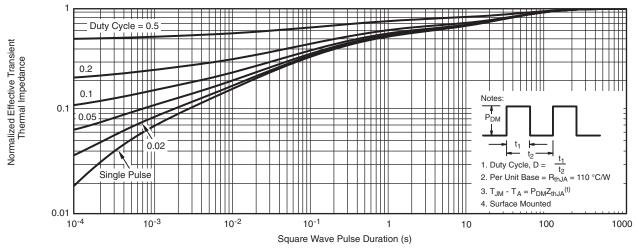




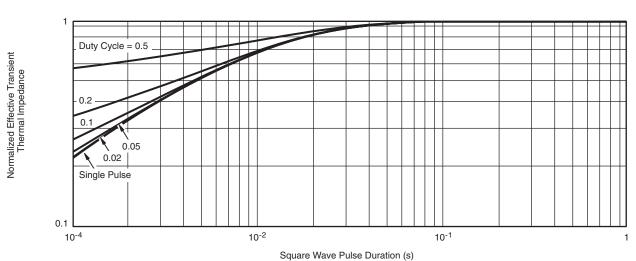
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit



N-CHANNEL TYPICAL CHARACTERISTICS $T_A = 25$ °C, unless otherwise noted

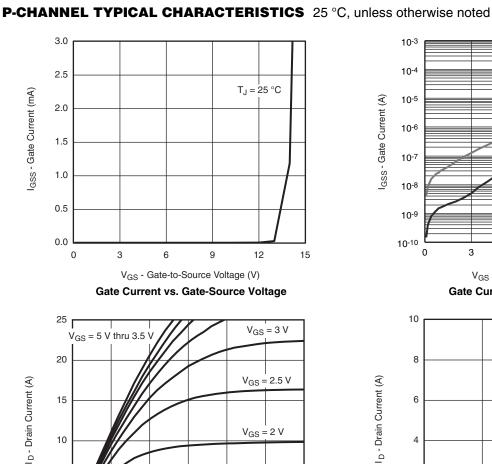


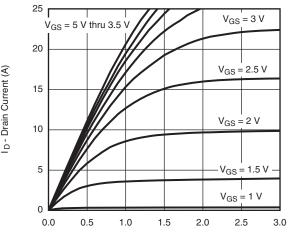
Normalized Thermal Transient Impedance, Junction-to-Ambient



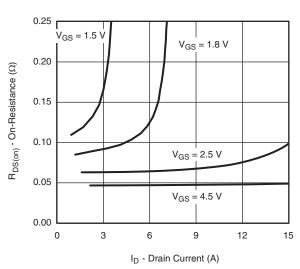
Normalized Thermal Transient Impedance, Junction-to-Case



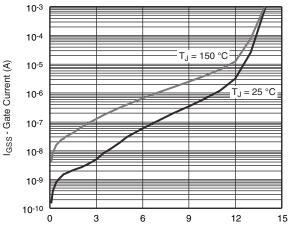




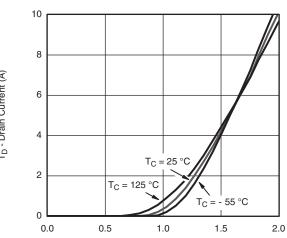
V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics**



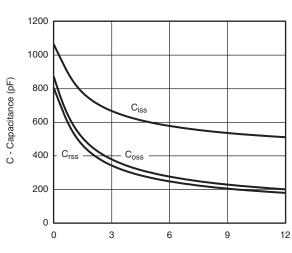
On-Resistance vs. Drain Current and Gate Voltage



V_{GS} - Gate-to-Source Voltage (V) Gate Current vs. Gate-Source Voltage



V_{GS} - Gate-to-Source Voltage (V) **Transfer Characteristics**



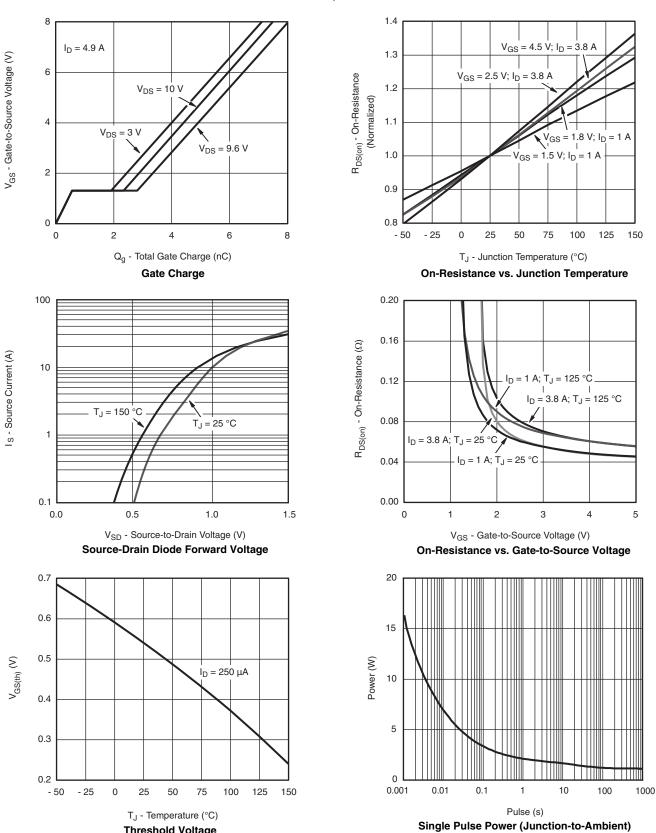
V_{DS} - Drain-to-Source Voltage (V)

Capacitance





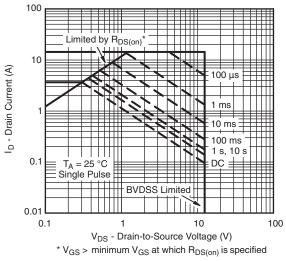
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Threshold Voltage

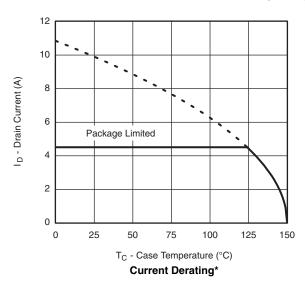


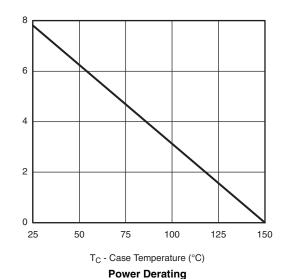
P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Safe Operating Area, Junction-to-Ambient

Power Dissipation (W)

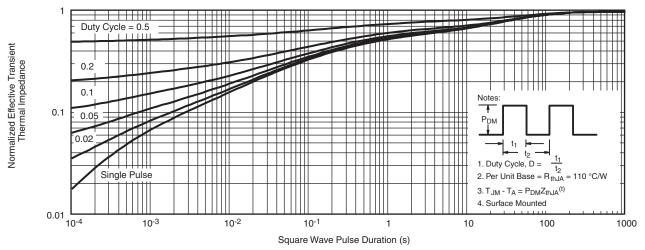




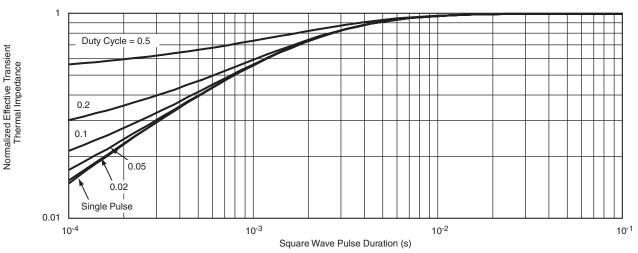
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P-CHANNEL TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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